

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination TOHJI ET AL.	
			Examiner Patricia L. Hailey	Art Unit 1755	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,484,992	11-1984	Buhler et al.	204/157.52
*	B	US-6,572,829	06-2003	Linkous et al.	422/186.03
*	C	US-6,248,218	06-2001	Linkous et al.	204/157.49
*	D	US-4,863,608	09-1989	Kawai et al.	210/638
*	E	US-4,041,140	08-1977	Nitta et al.	264/643
*	F	US-4,461,753	07-1984	Suzuki et al.	423/566.1
*	G	US-4,242,374	12-1980	Sansregret, Joseph L.	427/76
*	H	US-4,197,122	04-1980	Kawashima et al.	430/94
*	I	US-6,051,614	04-2000	Hirai et al.	516/20
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	06-148172	05-1994	Japan	Kitamura	G01N 33/18
	O	10-310401	11-1998	Japan	Ono et al.	C01B 3/04
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.